


<b>Search Notes</b>  	<b>Application/Control No.</b>  10031988	<b>Applicant(s)/Patent Under Reexamination</b>  NADAOKA ET AL.
	<b>Examiner</b>  Chin, Christopher L.	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner
Updated search history		10/16/2006	LYL
Updated search		6/12/08	CC
Updated search		12/6/08	CC

SEARCH NOTES		
Search Notes	Date	Examiner
Updated search history	10/16/2006	LYL
New EAST search (see attached search history)	10/16/2006	LYL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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